

FDC6000NZ

Dual N-Channel 2.5V Specified PowerTrench® MOSFET

General Description

This N-Channel 2.5V specified MOSFET is a rugged gate version of Fairchild's Semiconductor's advanced PowerTrench process. It has been optimized for power management applications with a wide range of gate drive voltage (2.5V - 12V). Packaged in FLMP SSOT-6, the $R_{\rm DS(ON)}$ and thermal properties of the device are optimized for battery power management applications.

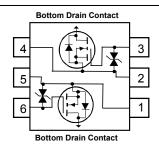
Applications

- Battery management/Charger Application
- Load switch

Features

- 6.5 A, 20 V $R_{DS(ON)} = 20 \text{ m}\Omega$ @ $V_{GS} = 4.5 \text{ V}$ $R_{DS(ON)} = 28 \text{ m}\Omega$ @ $V_{GS} = 2.5 \text{ V}$
- ESD protection diode (note 3)
- High performance trench technology for extremely low $R_{\mbox{\scriptsize DS(ON)}}$
- FLMP SSOT-6 package: Enhanced thermal performance in industry-standard package size





MOSFET Maximum Ratings T_A=25°C unless otherwise noted

| Symbol | Parameter | | Ratings | |
|-----------------------------------|--|-----------|-------------|----|
| V _{DSS} | Drain-Source Voltage | | 20 | V |
| V _{GSS} | Gate-Source Voltage | | ±12 | V |
| I _D | Drain Current - Continuous | (Note 1a) | 7.3 | А |
| | - Pulsed | | 20 | |
| P _D | Power Dissipation for Dual Operation | (Note 1a) | 1.6 | W |
| | Power Dissipation for Single Operation | (Note 1a) | 1.8 | |
| | | (Note 1b) | 1.2 | |
| T _J , T _{STG} | Operating and Storage Junction Temperature Range | | -55 to +150 | °C |

Thermal Characteristics

| $R_{\theta JA}$ | Thermal Resistance, Junction-to-Ambient | (Note 1a) | 68 | °C/W |
|-----------------|---|-----------|----|------|
| $R_{	heta Jc}$ | Thermal Resistance, Junction-to-Case | (Note 1a) | 1 | |

Package Marking and Ordering Information

| Device Marking | Device | Reel Size | Tape width | Quantity |
|----------------|-----------|-----------|------------|------------|
| .0NZ | FDC6000NZ | 7" | 8mm | 3000 units |

| Symbol | Parameter | Test Conditions | Min | Тур | Max | Units |
|---------------------------------------|---|---|-----|--------------------------------------|----------------------------|-------|
| Off Char | acteristics | | | 1 | | |
| BV _{DSS} | Drain–Source Breakdown Voltage | $V_{GS} = 0 \text{ V}, \qquad I_{D} = 250 \mu\text{A}$ | 20 | | | V |
| ΔBV _{DSS} ΔT _J | Breakdown Voltage Temperature Coefficient | I _D = 250 μA, Referenced to 25°C | | 14 | | mV/°C |
| I _{DSS} | Zero Gate Voltage Drain Current | $V_{DS} = 16 \text{ V}, \qquad V_{GS} = 0 \text{ V}$ | | | 1 | μΑ |
| I _{GSS} | Gate-Body Leakage | $V_{GS} = \pm 12 \text{ V}, V_{DS} = 0 \text{ V}$ | | | ± 10 | μА |
| On Char | acteristics (Note 2) | | | | | |
| $V_{GS(th)}$ | Gate Threshold Voltage | $V_{DS} = V_{GS}$, $I_D = 250 \mu A$ | 0.6 | 0.9 | 1.5 | V |
| $\Delta V_{GS(th)}$ ΔT_{J} | Gate Threshold Voltage Temperature Coefficient | I _D = 250 μA, Referenced to 25°C | | -4 | | mV/°C |
| R _{DS(on)} | Static Drain–Source On–Resistance | $\begin{array}{cccccccccccccccccccccccccccccccccccc$ | | 16.5 16.8 19.2 22.5 22.8 | 20 21 24 28 30 | mΩ |
| g _{FS} | Forward Transconductance | $V_{DS} = 5 \text{ V}, \qquad I_{D} = 6.5 \text{ A}$ | | 30 | | S |
| Dvnamic | Characteristics | | | • | | |
| C _{iss} | Input Capacitance | $V_{DS} = 10 \text{ V}, \qquad V_{GS} = 0 \text{ V},$ $f = 1.0 \text{ MHz}$ | | 840 | | pF |
| C _{oss} | Output Capacitance | | | 210 | | pF |
| C _{rss} | Reverse Transfer Capacitance | | | 100 | | pF |
| R _G | Gate Resistance | V _{GS} = 15 mV, f = 1.0 MHz | | 2.3 | | Ω |
| Switchin | g Characteristics (Note 2) | • | | - | | |
| $t_{d(on)}$ | Turn-On Delay Time | $V_{DD} = 10 \text{ V}, \qquad I_{D} = 1 \text{ A}, \\ V_{GS} = 4.5 \text{ V}, \qquad R_{GEN} = 6 \Omega$ | | 10 | 20 | ns |
| t _r | Turn-On Rise Time | | | 15 | 27 | ns |
| $t_{d(off)}$ | Turn-Off Delay Time | | | 18 | 32 | ns |
| t _f | Turn-Off Fall Time | | | 9 | 18 | ns |
| Q_g | Total Gate Charge | $V_{DS} = 10 \text{ V}, \qquad I_{D} = 6.5 \text{ A}, $ $V_{GS} = 4.5 \text{ V}$ | | 8 | 11 | nC |
| Q_{gs} | Gate–Source Charge | | | 1.5 | | nC |
| Q_{gd} | Gate-Drain Charge | | _ | 2.1 | | nC |
| Drain–Sc | ource Diode Characteristics a | and Maximum Ratings | | | | |
| Is | Maximum Continuous Drain-Source | | | | 1.25 | Α |
| V_{SD} | Drain-Source Diode Forward Voltage | $V_{GS} = 0 \text{ V}, I_S = 1.25 \text{A} \text{(Note 2)}$ | | 0.7 | 1.2 | V |

Electrical Characteristics

T_A = 25°C unless otherwise noted

| Symbol | Parameter | Test Conditions | Min | Тур | Max | Units | |
|-----------------|--|---|-----|-----|-----|-------|--|
| Drain-Sc | Drain-Source Diode Characteristics and Maximum Ratings | | | | | | |
| t _{rr} | Diode Reverse Recovery Time | $I_F = 6.5 \text{ A}, d_{iF}/d_t = 100 \text{ A}/\mu\text{s}$ | | 16 | | nS | |
| Q _{rr} | Diode Reverse Recovery Charge | | | 4.3 | | nC | |

NOTES:

1. R_{UJA} is the sum of the junction-to-case and case-to-ambient thermal resistance where the case thermal reference is defined as the solder mounting surface of the

drain pins. $R_{\theta JC}$ is guaranteed by design while $R_{\theta CA}$ is determined by the user's board design.



a) 68°C/W when mounted on a 1in² pad of 2 oz copper (Single Operation).

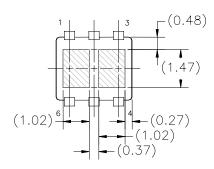


b) 102°C/W when mounted on a minimum pad of 2 oz copper (Single Operation).

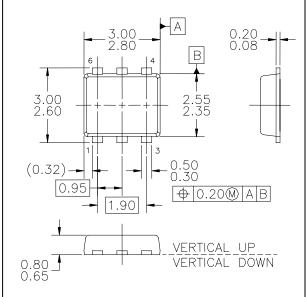
Scale 1: 1 on letter size paper

- **2.** Pulse Test: Pulse Width < 300μ s, Duty Cycle < 2.0%
- 3. The diode connected between the gate and source serves only as protection against ESD. No gate overvoltage rating is implied.
- 4. Electrical characterization and datasheet limits was based on a single source configuration (pin 2 & 5 no connection).

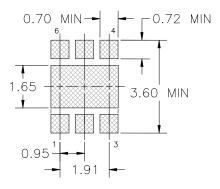
Dimensional Outline and Pad Layout



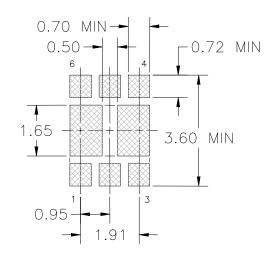
Bottom View



Top View



Recommended Landing Pattern For Common Drain Configuration

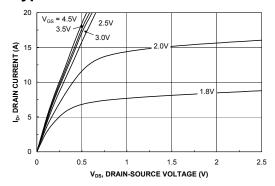


Recommended Landing Pattern For Standard Dual Configuration

NOTES: UNLESS OTHERWISE SPECIFIED

ALL DIMENSIONS ARE IN MILLIMETERS.

Typical Characteristics



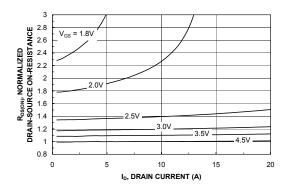
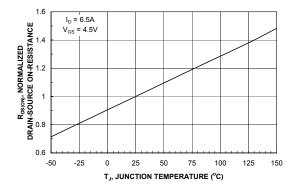


Figure 1. On-Region Characteristics.

Figure 2. On-Resistance Variation with Drain Current and Gate Voltage.



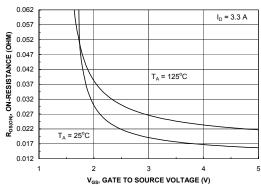
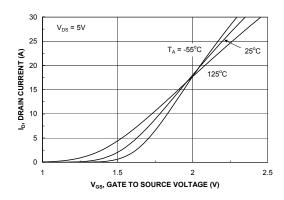


Figure 3. On-Resistance Variation with Temperature.

Figure 4. On-Resistance Variation with Gate-to-Source Voltage.



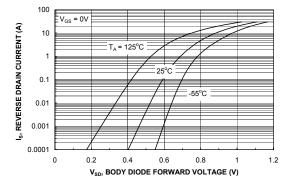
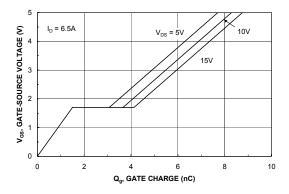


Figure 5. Transfer Characteristics.

Figure 6. Body Diode Forward Voltage Variation with Source Current and Temperature.

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Typical Characteristics



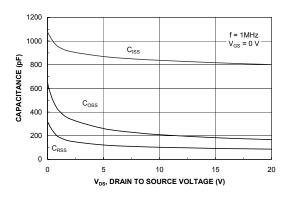
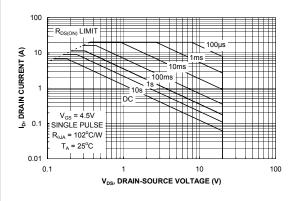


Figure 7. Gate Charge Characteristics.





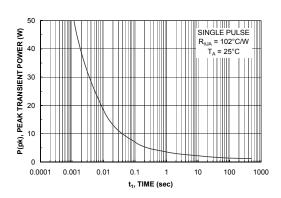


Figure 9. Maximum Safe Operating Area.

Figure 10. Single Pulse Maximum Power Dissipation.

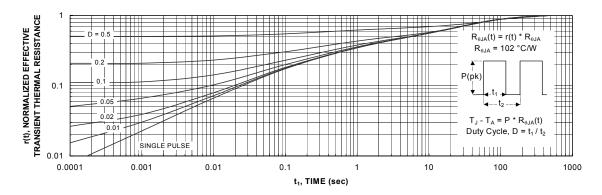


Figure 11. Transient Thermal Response Curve.

Thermal characterization performed using the conditions described in Note 1b. Transient thermal response will change depending on the circuit board design.

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